## Notic of R ferenc s Cited Application/Control No. 10/840,154 Examiner Than Nguyen Applicant(s)/Patent Under Reexamination FAHS ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,051,192	05-2006	Chaudhry et al.	712/218
*	В	US-6,438,673	08-2002	Jourdan et al.	711/213
*	С	US-6,725,338	04-2004	Gomez et al.	711/137
*	D	US-7,010,648	03-2006	Kadambi et al.	711/118
_	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	7	US-			
	Κ	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					¥ ,
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.